

Application/Control No. 10/802,079

Examiner Chen-Wen Jiang Applicant(s)/Patent under Reexamination

FRANKE ET AL. Art Unit

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3744

	INTERNATIONAL CLASSIFICATION													
CLASS SUBCLAS				.ASS			CL	AIMED		NON-CLAIMED				
236			93R		G	05	D	23	/00			/		
CROSS REFERENCES						01	N	25	/18					
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165	287				G	01	K	17	/00			1		
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(Assistant Examiner) (Date) 801 (Legal Instruments Examiner) (Date)

U.S. Patent and Trademark Office

CHENWEN JIANG 8/1/07 PRIMARY EXAMINER (Primary Examiner) 0.G. Print Claim(s) Print Fig. (Date)

⊠ c	laims	aims renumbered in the same order as presented by applicant						cant	☐ CPA			☐ T.D.			☐ R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
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	4			34			64]		94			124			154			184
	5			35			65	1		95		-	125			155			185
	6			36			66	1		96			126			156			186
	7			37			67	1		97			127			157			187
	8			38			68	1		98			128			158			188
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	10			40			70]		100			130			160			190
	11			41			71]		101			131			161			191
	12			42			72]		102			132			162			192
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	25			55			85			115			145			175			205
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	28			58			88			118			148			178			208
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	30			60			90			120			150			180			210

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